## Supporting Information

Tunable Dielectric Properties of Parylene Dielectric Layer through Surface-Modulation by Click Chemistry

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Fig. S1. a) Reaction scheme for synthesizing the 4-ethynyl[2.2]paracyclophane, and its b) <sup>1</sup>H NMR, c) <sup>13</sup>C NMR spectra.



**Fig. S2.** a) Electrical property of Pa-E thin-film. b) Hysteresis behavior and c) output curves of IGZO TFTs with Pa-E gate dielectric.





Fig. S3. Contact angle results showing different surface properties against water after surface-click reaction.



Fig. S4. Cross-sectional FIB-SEM images of MIM devices fabricated by clicked parylene.



Fig. S5. Dielectric properties of Pa-E with a) Ba, b) Ta, and c) Bioa modulator.



**Figure S6.** a) Candidate modulators that can be used in this system, b) N1s narrow scan of XPS demonstrating the successful click reaction with Pa-E, c) Changes in the dielectric properties of the material after reaction with these modulators.



Fig. S7. Dielectric properties of parylene-C a) before and after click reaction with b) Ba, and c) Ta.



**Fig. S8.** Dielectric properties of Pa-E with modulators: a) Ba, b) Aa, c) Ta, and d) Bioa, after 1 month of storage in air at ambient conditions.



Fig. S9. Electrical properties of Pa-E surface modulated by a) Ba, b) Aa, c) Ta, and d) Bioa.



Fig. S10. IGZO TFTs with Pa-E gate dielectric tuned by a) Ba, b) Ta, and c) Bioa modulator.



Figure S11. Hysteresis behavior of IGZO TFTs with Pa-E modulated by a) Ba, b) Aa, c) Ta, and d) Bioa



Gate (AI) Dielectric Layer(Pa-E@Ba) Semi-conductor(IGZO)

Fig. S12. Cross-sectional image of oxide TFTs with surface-modulated dielectrics.



Fig. S13. Output curves of IGZO TFTs with Pa-E with a) Ba, b) Aa, c) Ta, and d) Bioa modulator.

	Pa-E@Ba	Pa-E@Aa	Pa-E@Ta	Pa-E@Bioa
% of Click Depth [%]	1.65	0.61	1.13	0.65
Clicked Depth [nm]	2.95	1.04	1.94	1.09

**Table S1.** Summary of the information about the depth at which the click reaction occurred from ToF-SIMS data and their real thickness values calibrated by ellipsometric analysis